



Model: WD WD6000BKHG S/N: WXD1E61EFA71

Disk Erasure Report





Business Name: GridJet

Business Address:

Contact Name: **GDW-LDS-6** Contact Phone:

Customer Details

Name: Gridjet

Address:

Contact Name: Contact Phone:

Disk Information

Make/Model: WD WD6000BKHG Serial: WXD1E61EFA71

Size(Apparent): 600 GB, 600127266816 bytes Bus: SAS

Size(Real): 600 GB, 600127266816 bytes

Disk Erasure Details

Start time: 2025/02/16 17:21:40 End time: 2025/02/16 22:04:10

Duration: 04:42:30 See Warning!

Method: PRNG Stream PRNG algorithm: XORshiro256

Final Pass(Zeros/Ones/None): Zeros Verify Pass(Last/All/None): Verify Last

*Bytes Erased: 600127266816, (100.00%) Rounds(completed/requested): 1/1

HPA/DCO: Unknown HPA/DCO Size: Unknown

Errors(pass/sync/verify): 0/0/0 Throughput: 106 MB/sec

Information: Warning HPA/DCO data unavailable, can not determine hidden sector status.

Technician/Operator ID Signature:

Name/ID: Auto Wipe

^{*} bytes erased: The amount of drive that's been erased at least once





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smartctl 7.2 2020-12-30 r5155 [x86_64-linux-5.14.0-503.23.1.el9_5.x86_64] (local build) copyright (c) 2002-20, bruce allen, christian franke, www.smartmontools.org

=== start of information section === vendor: WD

WD6000BKHG product: D1V8 revision: compliance: SPC-4

user capacity: 600,127,266,816 bytes [600 GB]

logical block size: 512 bytes rotation rate: 10000 rpm 2.5 inches form factor:

logical unit id: 0x50014ee355658004 serial number: WXD1E61EFA71

device type: disk

transport protocol: SAS (SPL-3)

local time is: Sun Feb 16 22:04:12 2025 GMT

local time is: Sun Feb 16 22:04:12 2025 GMT smart support is: Available - device has SMART capability.

smart support is: Enabled

temperature warning: Disabled or Not Supported

=== start of read smart data section ===

smart health status: OK

current drive temperature: 36 C drive trip temperature: 64 C

accumulated power on time, hours:minutes 110899:04

manufactured in week of year 2010

specified cycle count over device lifetime: 1048576

accumulated start-stop cycles: 8

specified load-unload count over device lifetime: 1114112

accumulated load-unload cycles: 8 elements in grown defect list: 7

error counter log:

gigabytes rected by total correction rereads/ errors algorithm errors corrected by total uncorrected ecc processed fast | delayed rewrites corrected invocations 128677635 686407 718216 129364042 689420 [10⁹ bytes] errors read: 1.811 Ω write: 1752345 2358531 0 4110876 2358531 Ω 5473 verify: 585345 4392 589737 4598 0.302 Ω

non-medium error count: 2244313

smart self-test log

segment lifetime lba_first_err [sk asc asq] status num test description number (hours) # 1 background long completed
2 background short completed 32 3 - [-- [- -32 1

long (extended) self-test duration: 8460 seconds [141.0 minutes]